

Search Notes

Application/Control No.

10/797,198

Examiner

Hieu P. Nguyen

Applicant(s)/Patent under
Reexamination

KOIMORI ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	289	2/16/2006	
330	296	2/16/2006	
330	277	2/16/2006	
330	307	2/16/2006	
330	285	2/16/2006	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
US-PGPUB		2/16/2006	HN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST UPDATE SEARCH SEE PRINT OUT	2/16/2006	HN